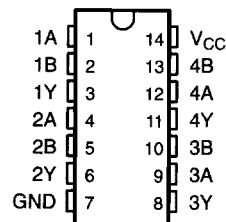


# SN74LVC08 QUADRUPLE 2-INPUT POSITIVE-AND GATE

JANUARY 1993

- **Space-Saving Package Option:  
Shrink Small-Outline Package (DB)  
Features EIAJ 0.65-mm Lead Pitch**
- **EPIC™ (Enhanced-Performance Implanted  
CMOS) Submicron Process**
- **Designed to Facilitate Incident Wave  
Switching for Line Impedances of 50 Ω or  
Greater**
- **Typical  $V_{OLP}$  (Output Ground Bounce)  
< 0.8 V at  $V_{CC} = 3.3$  V,  $T_A = 25^\circ\text{C}$**
- **Typical  $V_{OHV}$  (Output  $V_{OH}$  Undershoot)  
> 2 V at  $V_{CC} = 3.3$  V,  $T_A = 25^\circ\text{C}$**
- **ESD Protection Exceeds 2000 V Per  
MIL-STD-883C, Method 3015; Exceeds  
200 V Using Machine Model (C = 200 pF,  
R = 0)**
- **Latch-Up Performance Exceeds 250 mA  
Per JEDEC Standard JESD-17**
- **Package Options Include Plastic  
Small-Outline and Thin Shrink  
Small-Outline Packages**

D, DB, OR PW PACKAGE  
(TOP VIEW)



## description

This quadruple 2-input positive-AND gate is designed for 2.7-V to 3.6-V  $V_{CC}$  operation.

The SN74LVC08 performs the Boolean functions  $Y = A \cdot B$  or  $Y = \overline{A + B}$  in positive logic.

The SN74LVC08 is packaged in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN74LVC08 is characterized for operation from  $-40^\circ\text{C}$  to  $85^\circ\text{C}$ .

FUNCTION TABLE  
(each gate)

INPUTS		OUTPUT
A	B	Y
H	H	H
L	X	L
X	L	L

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PRODUCT PREVIEW information concerns products in the formative or design phase of development. Characteristic data and other specifications are design goals. Texas Instruments reserves the right to change or discontinue these products without notice.

TEXAS  
INSTRUMENTS

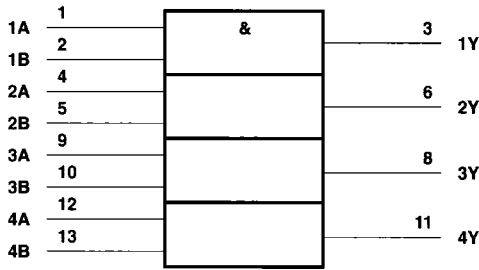
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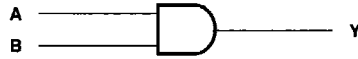
# SN74LVC08 QUADRUPLE 2-INPUT POSITIVE-AND GATE

JANUARY 1993

## logic symbol†



## logic diagram, each gate (positive logic)



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, $V_{CC}$ .....	-0.5 V to 4.6 V
Input voltage range, $V_I$ (see Note 1) .....	-0.5 V to 4.6 V
Output voltage range, $V_O$ (see Notes 1 and 2) .....	-0.5 V to $V_{CC} + 0.5$ V
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	-50 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ ) .....	$\pm 50$ mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ ) .....	$\pm 50$ mA
Continuous current through $V_{CC}$ or GND pins .....	$\pm 100$ mA
Maximum power dissipation at $T_A = 55^\circ\text{C}$ (in still air):	
D package .....	0.7 W
DB package .....	0.4 W
PW package .....	0.4 W
Storage temperature range .....	$-65^\circ\text{C}$ to $150^\circ\text{C}$

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.  
2. This value is limited to 4.6 V maximum.

## recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
$V_{CC}$	Supply voltage	2.7	3.6	V
$V_{IH}$	High-level input voltage	$V_{CC} = 2.7$ V to $3.6$ V		V
$V_{IL}$	Low-level input voltage	$V_{CC} = 2.7$ V to $3.6$ V		V
$V_I$	Input voltage	0	$V_{CC}$	V
$V_O$	Output voltage	0	$V_{CC}$	V
$I_{OH}$	High-level output current	$V_{CC} = 2.7$ V	-12	mA
		$V_{CC} = 3$ V	-24 <sup>§</sup>	
$I_{OL}$	Low-level output current	$V_{CC} = 2.7$ V	12	mA
		$V_{CC} = 3$ V	24 <sup>§</sup>	
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V
$T_A$	Operating free-air temperature	-40	85	$^\circ\text{C}$

NOTE 3: Unused or floating inputs must be held high or low.

<sup>§</sup> Current duty cycle  $\leq 50\%$ ,  $f \geq 1$  kHz

PRODUCT PREVIEW

**SN74LVC08**  
**QUADRUPLE 2-INPUT POSITIVE-AND GATE**

JANUARY 1993

**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS	$V_{CC}^{\dagger}$	MIN	TYP	MAX	UNIT
$V_{IK}$	$I_I = -18 \text{ mA}$	2.7 V			-1.2	V
$V_{OH}$	$I_{OH} = -100 \mu\text{A}$	MIN to MAX	$V_{CC} - 0.2$			V
	$I_{OH} = -12 \text{ mA}$	2.7 V	2.2			
		3 V	2.4			
	$I_{OH} = -24 \text{ mA}$	3 V	2			
$V_{OL}$	$I_{OL} = 100 \mu\text{A}$	MIN to MAX			0.2	V
	$I_{OL} = 12 \text{ mA}$	2.7 V			0.4	
	$I_{OL} = 24 \text{ mA}$	3 V			0.55	
$I_I$	$V_I = V_{CC} \text{ or GND}$	3.6 V			$\pm 5$	$\mu\text{A}$
$I_{OZ}$	$V_O = V_{CC} \text{ or GND}$	3.6 V			$\pm 10$	$\mu\text{A}$
$I_{CC}$	$V_I = V_{CC} \text{ or GND, } I_O = 0$	3.6 V			20	$\mu\text{A}$
$\Delta I_{CC}$	$V_{CC} = 3 \text{ V to } 3.6 \text{ V,}$ Other inputs at $V_{CC} \text{ or GND}$	One input at $V_{CC} - 0.6 \text{ V,}$			500	$\mu\text{A}$
$C_i$	$V_I = V_{CC} \text{ or GND}$	3.3 V	TBD			pF
$C_o$	$V_O = V_{CC} \text{ or GND}$	3.3 V	TBD			pF

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate values under recommended operating conditions.

**PRODUCT PREVIEW**

